# Chapter 6 Testability Analysis

可測度分析法



#### **Outline**

- Introduction
- SCOAP
- COP
- High-level Testability

#### **Testability Analysis**



- Applications
  - To give early warnings about the test problems
    - Guide the selection of test points to improve testability.
    - Automate the "Design for Testability" problem
  - To provide guidance in ATPG
    - For example, determine the "hardest" & "easiest" inputs in backtrace of PODEM
- Complexity should be simpler than ATPG and fault simulation
  - Need to be linear or almost linear in terms of circuit size
- Topology analysis
  - Only the structure of the circuit is analyzed
  - No test vectors are involved
  - Only an approximation
    - reconvergent fanouts cause inaccuracy

#### **Testability Measures**



- Controllability
  - The difficulty of setting a particular logic signal to 0 or 1.
- Observability
  - The difficulty of observing the logic state of a signal.

#### **SCOAP**

## Sandia Controllability/Observability Analysis Program *Goldstein, DAC 1980*



SCOAP computes 6 numbers for each node N.

	0- controllability	1- controllability	Observability
Combinational	CC <sub>0</sub> (N)	CC <sup>1</sup> (N)	CO(N)
Sequential	SC <sup>0</sup> (N)	SC <sup>1</sup> (N)	SO(N)

# **Combinational SCOAP Measures**



- Combinational controllability
  - CC<sup>0</sup>(N), CC<sup>1</sup>(N)
  - Related to the minimum number of combinational node (PI or gate output) assignments required to justify a 0 or 1 on a node N.
- Combinational observability
  - CO(N)
  - Related to the number of gates between N and PO's, and
  - the minimum number of PI assignments required to propagate the logical value on node N to a primary output.

### $CC^0(N) & CC^1(N)$



	CC <sup>0</sup> ( <i>y</i> )	CC <sup>1</sup> (y)
$x_1 \longrightarrow y$	min[CC <sup>0</sup> (x <sub>1</sub> ),CC <sup>0</sup> (x <sub>2</sub> )] +	$CC^{1}(x_{1}) + CC^{1}(x_{2}) + 1$
$x_1 \longrightarrow y$	$CC^{0}(x_{1}) + CC^{0}(x_{2}) + 1$	min[CC <sup>1</sup> ( $x_1$ ),CC <sup>1</sup> ( $x_2$ )] +
$X_1 \longrightarrow Y$	min[CC <sup>0</sup> ( $x_1$ ) + CC <sup>0</sup> ( $x_2$ ), CC <sup>1</sup> ( $x_1$ ) + CC <sup>1</sup> ( $x_2$ )] + 1	min[CC <sup>0</sup> ( $x_1$ ) + CC <sup>1</sup> ( $x_2$ ), CC <sup>1</sup> ( $x_1$ ) + CC <sup>0</sup> ( $x_2$ )] + 1
<i>x</i> — <i>y</i>	$CC^{1}(x) + 1$	$CC^{0}(x) + 1$
Primary inputs	1	1

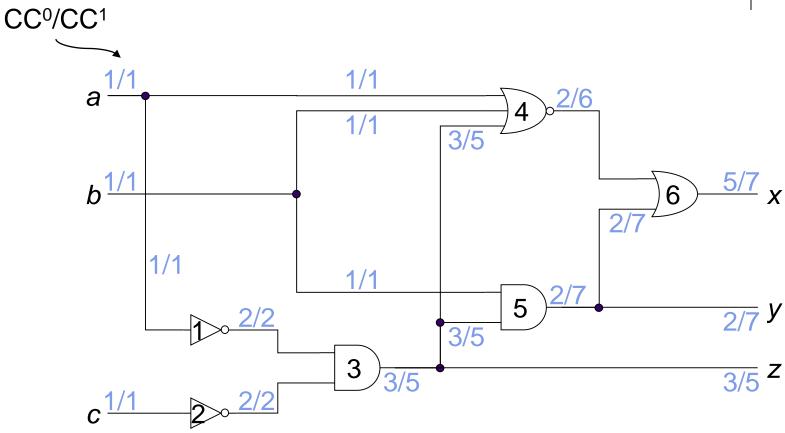
### CO(N)



	$CO(x_1)$
$X_1 \longrightarrow y$	$CO(y) + CC^{1}(x_2) + 1$
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	$CO(y) + CC^{0}(x_{2}) + 1$
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	$CO(y) + min[CC^{0}(x_{2}), CC^{1}(x_{2})] + 1$
x <sub>1</sub> — y	CO(y) + 1
$x_1 - y_1 - y_2$	min[CO( $y_1$ ),CO( $y_2$ )]
Primary outputs	0

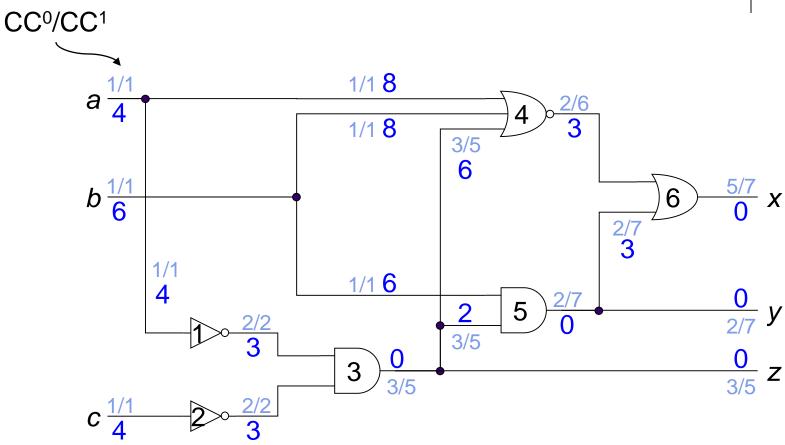
### **An Example – Controllability**



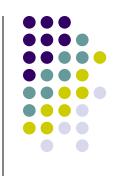


#### **An Example – Observability**





#### **Sequential SCOAP Measures**



- Sequential controllability
  - SC<sup>0</sup>(N), SC<sup>1</sup>(N)
  - Estimate the minimum number of sequential node (FF output) assignments required to justify a 0 or 1 on a node N.
- Sequential observability
  - SO(N)
  - Related to the number of FF's between N and PO's, and
  - the minimum number of FF assignments required to propagate the logical value on node N to a primary output.

## Computing the Sequential SCOAP Measures



- Computation of SC<sup>0</sup>(N), SC<sup>1</sup>(N), and SO(N) is similar to that of CC<sup>0</sup>(N), CC<sup>1</sup>(N), and CO(N).
- The differences are
  - One increments the sequential measures by 1 only when signals propagate from FF inputs to Q or Q', or backwards.
  - Several iterations may be required for the controllability numbers to converge.

### Computing SC<sup>0</sup>(N) and SC<sup>1</sup>(N)



	SC <sup>0</sup> ( <i>y</i> )	SC <sup>1</sup> (y)
x <sub>1</sub> — y	min[SC $^{0}(x_{1})$ ,SC $^{0}(x_{2})$ ]	$SC^{1}(x_{1}) + SC^{1}(x_{2})$
$X_1 \longrightarrow Y$	$SC^0(x_1) + SC^0(x_2)$	min[SC $^{1}(x_{1})$ ,SC $^{1}(x_{2})$ ]
$X_1 \longrightarrow Y$	min[SC <sup>0</sup> ( $x_1$ ) + SC <sup>0</sup> ( $x_2$ ), SC <sup>1</sup> ( $x_1$ ) + SC <sup>1</sup> ( $x_2$ )]	min[SC <sup>0</sup> ( $x_1$ ) + SC <sup>1</sup> ( $x_2$ ), SC <sup>1</sup> ( $x_1$ ) + SC <sup>0</sup> ( $x_2$ )]
<i>x</i> — — <i>y</i>	SC <sup>1</sup> (x)	SC <sup>0</sup> (x)
Primary inputs	0	0

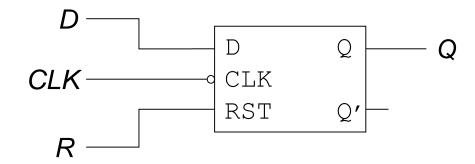
### **SO(N)**



	$SO(x_1)$
$X_1 \longrightarrow y$	$SO(y) + SC^{1}(x_{2})$
$x_1 \longrightarrow y$	$SO(y) + SC^0(x_2)$
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	$SO(y) + min[SC^{0}(x_{2}),SC^{1}(x_{2})]$
x <sub>1</sub> — y	SO(y)
$x_1 - y_1 - y_2$	min[SO( $y_1$ ),SO( $y_2$ )]
Primary outputs	0

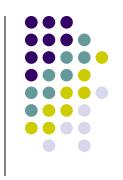
#### Flip-Flop

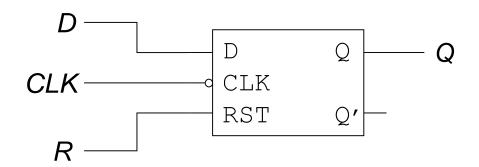




$$CC^{1}(Q) = CC^{1}(D) + CC^{1}(CLK) + CC^{0}(CLK) + CC^{0}(R)$$
  
 $SC^{1}(Q) = SC^{1}(D) + SC^{1}(CLK) + SC^{0}(CLK) + SC^{0}(R) + 1$ 

$$CC^{0}(Q) = min[CC^{1}(R) + CC^{0}(CLK),$$
  
 $CC^{0}(D) + CC^{1}(CLK) + CC^{0}(CLK) + CC^{0}(R)]$   
 $SC^{0}(Q) = min[SC^{1}(R) + SC^{0}(CLK),$   
 $SC^{0}(D) + SC^{1}(CLK) + SC^{0}(CLK) + SC^{0}(R)] + 1$ 





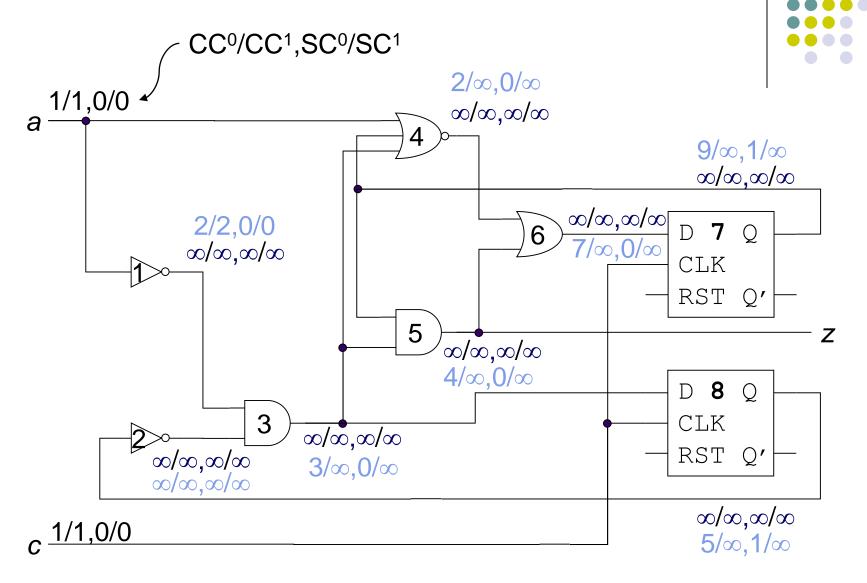
$$\begin{aligned} &\mathrm{CO}(D) = \mathrm{CO}(Q) + \mathrm{CC}^1(CLK) + \mathrm{CC}^0(CLK) + \mathrm{CC}^0(R) \\ &\mathrm{SO}(D) = \mathrm{SO}(Q) + \mathrm{SC}^1(CLK) + \mathrm{SC}^0(CLK) + \mathrm{SC}^0(R) + 1 \end{aligned}$$

## **Computing Testability Measures** for Sequential Circuits

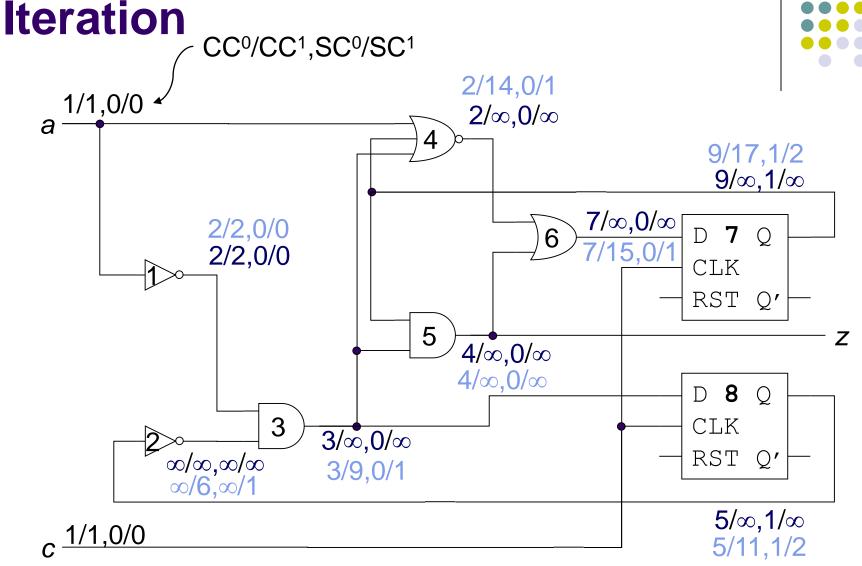


- 1. For all Pl's, set  $CC^0 = CC^1 = 1$  and  $SC^0 = SC^1 = 0$ .
- 2. For all other nodes, set  $CC^0 = CC^1 = \infty$  and  $SC^0 = SC^1 = \infty$ .
- Propagate controllability measures from Pl's to PO's.
   Iterate until the controllability numbers stabilize.
- 4. For all PO's, set CO = SO = 0.
- 5. For all other nodes, set  $CO = SO = \infty$ .
- 6. Propagate observability from PO's to Pl's.

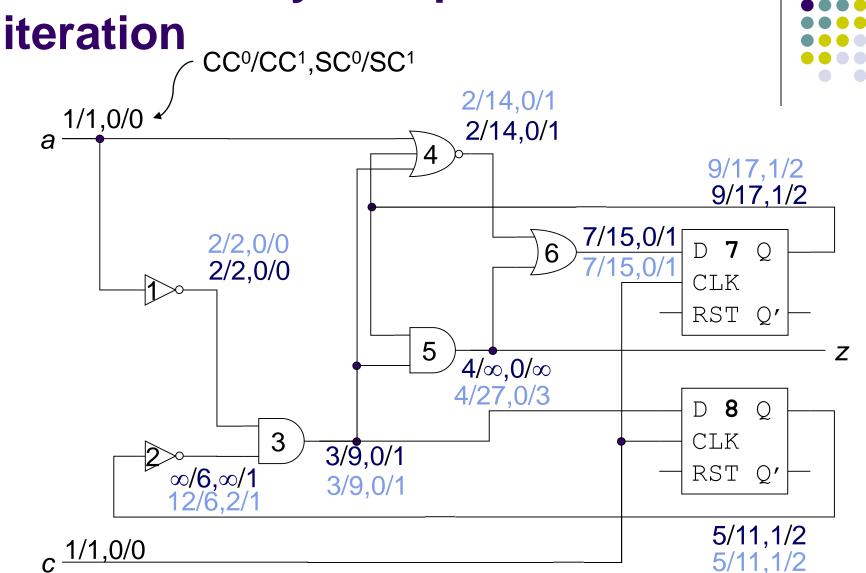
#### **Controllability Computation**



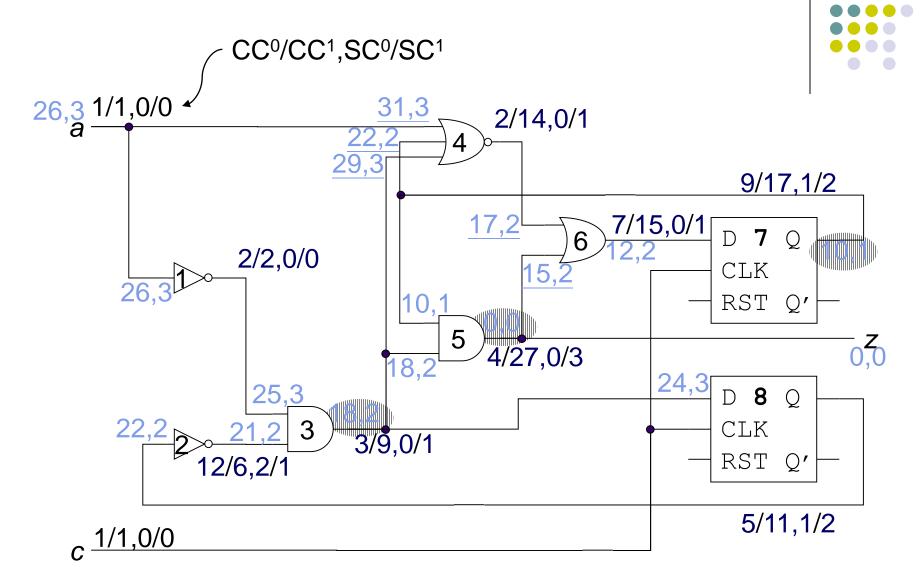
## Controllability Computation – 2nd



## **Controllability Computation – 3rd iteration**



#### **Observability Computation**



#### COP [F. Brglez, '84]



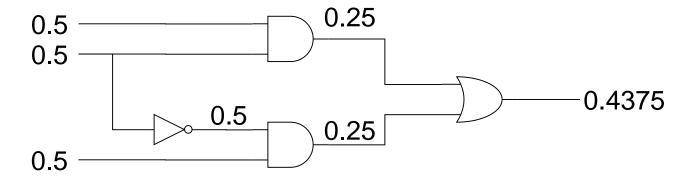
- C<sub>x</sub>: the probability of x being 1.
- $O_x$ : the probability of x being observed at a PO.

	$C_{x}$	O <sub>a</sub>
а — х	$C_x = C_a \times C_b$	$O_a = O_x \times C_b$
а — х	$C_x = 1 - (1 - C_a) \times (1 - C_b)$	$O_a = O_x \times (1 - C_b)$
x — a	$C_x = C_a = C_b$	$O_x = 1 - (1 - O_a) \times (1 - O_b)$

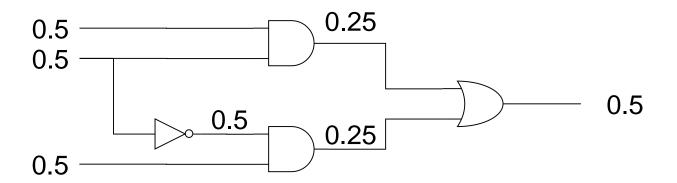
#### **An Example – Controllability**



#### **COP** values



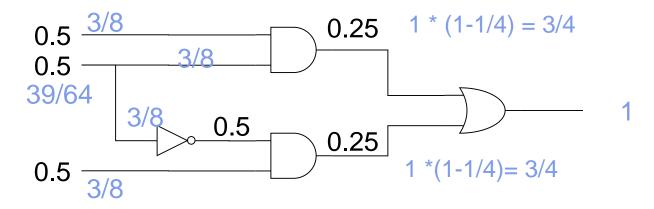
#### Actual contrallabilities



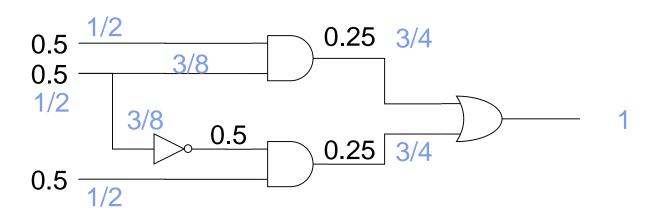
#### **An Example – Observability**



#### **COP** values



#### Actual observabilities



#### PODEM: Example (1/3)



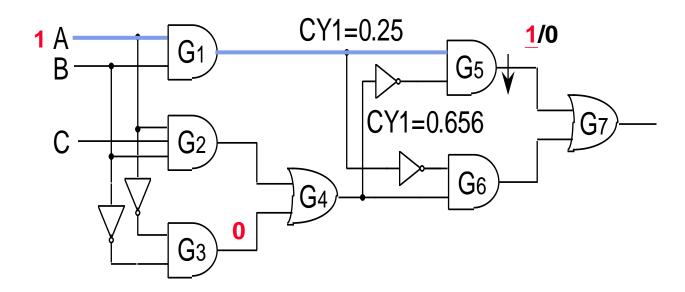
Initial objective=(G5,1).

G5 is an AND gate → Choose the hardest-1

→ Back-trace to (G1,1).

G1 is an AND gate → Choose the hardest-1

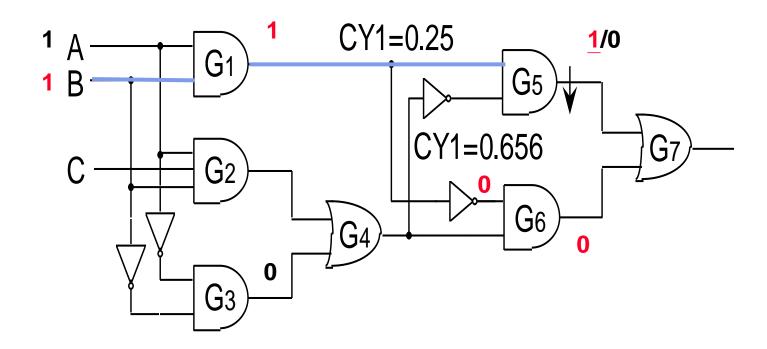
 $\rightarrow$  Arbitrarily, back-trace to (A,1). A is a PI  $\rightarrow$  Implication  $\rightarrow$  G3=0.



#### PODEM: Example (2/3)



The initial objective satisfied? No!  $\rightarrow$  Current objective=(G5,1). G5 is an AND gate  $\rightarrow$  Choose the hardest-1  $\rightarrow$  Back-trace to (G1,1). G1 is an AND gate  $\rightarrow$  Choose the hardest-1  $\rightarrow$  Arbitrarily, back-trace to (B,1). B is a PI  $\rightarrow$  Implication  $\rightarrow$  G1=1, G6=0.



#### PODEM: Example (3/3)



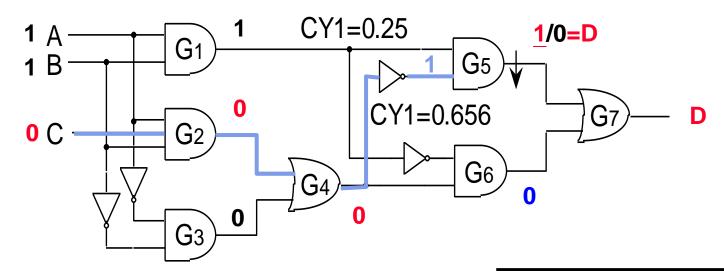
The initial objective satisfied? No!  $\rightarrow$  Current objective=(G5,1).

The value of G1 is known  $\rightarrow$  Back-trace to (G4,0).

The value of G3 is known  $\rightarrow$  Back-trace to (G2,0).

A, B is known  $\rightarrow$  Back-trace to (C,0).

C is a PI  $\rightarrow$  Implication  $\rightarrow$  G2=0, G4=0, G5=D, G7=D.

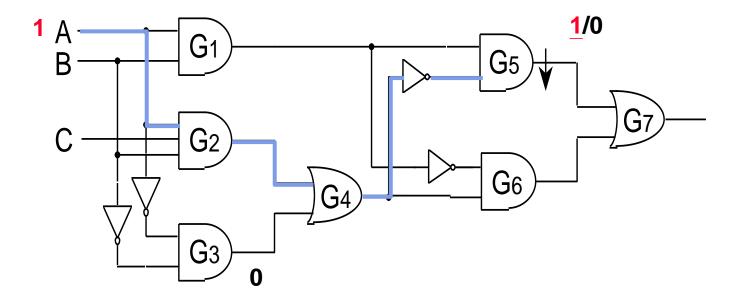


No backtracking!!

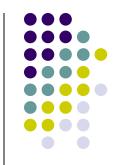
# If The Backtracing Is Not Guided (1/3)



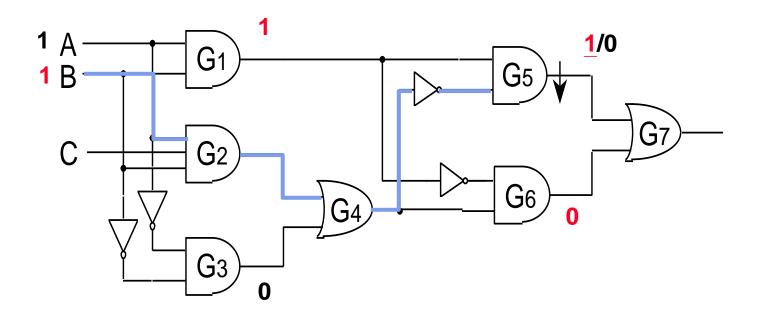
Initial objective=(G5,1). Choose path G5-G4-G2-A  $\rightarrow$  A=0. Implication for A=0  $\rightarrow$  G1=0, G5=0  $\rightarrow$  Backtracking to A=1. Implication for A=1  $\rightarrow$  G3=0.



# If The Backtracing Is Not Guided (2/3)



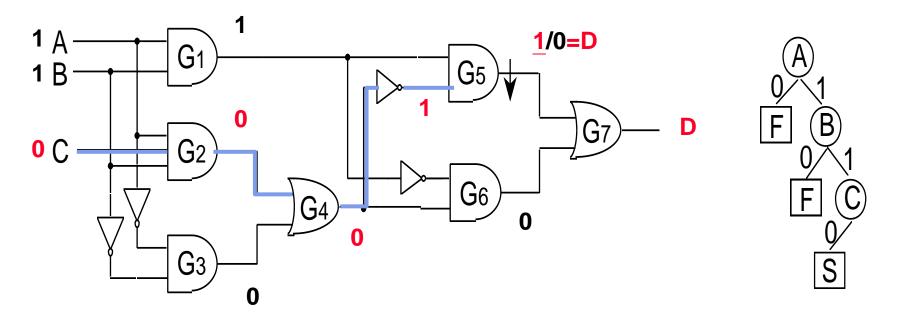
The initial objective satisfied? No!  $\rightarrow$  Current objective=(G5,1). Choose path G5-G4-G2-B  $\rightarrow$  B=0. Implication for B=0  $\rightarrow$  G1=0, G5=0  $\rightarrow$  Backtracking to B=1. Implication for B=1  $\rightarrow$  G1=1, G6=0.



# If The Backtracing Is Not Guided (3/3)



The initial objective satisfied? No!  $\rightarrow$  Current objective=(G5,1). Choose path G5-G4-G2-C  $\rightarrow$  C=0. Implication for C=0  $\rightarrow$  G2=0, G4=0, G5=D, G7=D.



Two times of backtracking!!

#### **High-Level Testability Analysis**

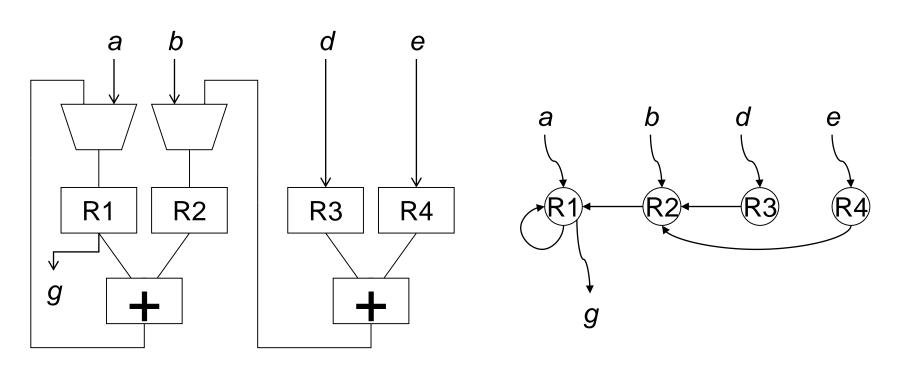


- Based on behavioral level circuit model.
- Usually part of the behavior synthesis program.
- To improve the testability at earlier design stage.

#### **Data Flow Graph (DFG)**

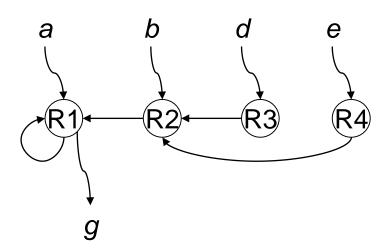


- Each node corresponds to a register.
- Each arc represents a combinational path between two registers.



## A High-Level Testability Measure – Sequential Depth

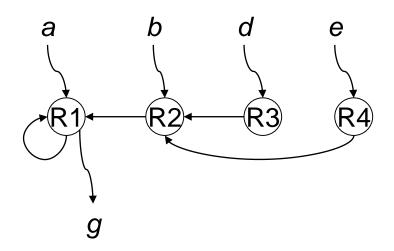
- The length of a sequential path between two nodes is the number of arcs along the path.
- The sequential depth between a pair of registers is the length of the shortest path between them.



$a \rightarrow g: 2$
$b \rightarrow g:3$
$d \rightarrow g: 4$
$e \rightarrow g: 4$

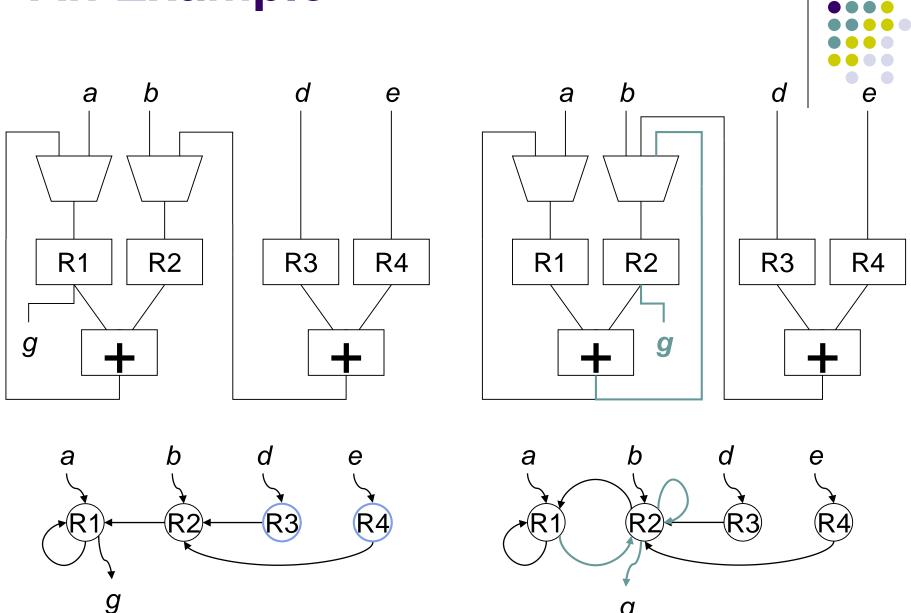
#### **Testability Enhancement**

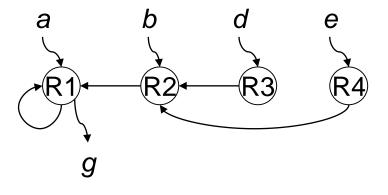
- Improve controllability and observability of registers.
  - Whenever possible, allocate a register to at least one Pl or PO.
- Reduce the sequential depth between a controllable and an observable registers.

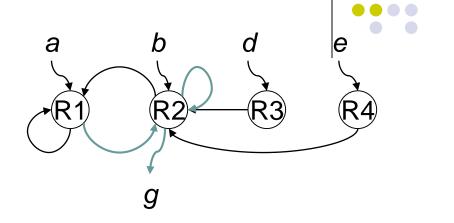


 $R1 \rightarrow R1:0$   $R2 \rightarrow R1:1$   $R3 \rightarrow R1:2$   $R4 \rightarrow R1:2$ 

#### An Example







R1  $\rightarrow$  R1:0 R2  $\rightarrow$  R1:1 R3  $\rightarrow$  R1:2 R4  $\rightarrow$  R1:2  $R1 \rightarrow R2 : 1$   $R2 \rightarrow R2 : 0$   $R3 \rightarrow R2 : 1$   $R4 \rightarrow R2 : 1$